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## UNITED STATES PATENT AND TRADEMARK OFFICE CERTIFICATE OF CORRECTION

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INVENTOR(S) : Christopher C. Chang et al.

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It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

## Column 10,

Line 16, "16. The component of claim 15, wherein the coating is." should read as follows:

-- 16. A component of a plasma etch reactor, the component comprising aluminum having an anodized or non-anodized plasma exposed surface, the component comprising an as-sprayed plasma sprayed coating on a plasma exposed surface of the component, the coating being a ceramic material selected from the group consisting of alumina, yttria, zirconia, silicon carbide, silicon nitride, boron carbide and boron nitride, and the coating having an as-sprayed surface roughness that promotes the adhesion of polymer deposits formed during etching of semiconductor substrates in the plasma etch reactor. --

Signed and Sealed this

Eighth Day of February, 2005

JON W. DUDAS
Director of the United States Patent and Trademark Office